

<b>Notice of References Cited</b>	Application/Control No. 10/593,632	Applicant(s)/Patent Under Reexamination MUKAI ET AL.	
	Examiner MARIA J. LAIOS	Art Unit 1795	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0244712	11-2005	Miyamoto et al.	429/223
*	B	US-7,344,803	03-2008	Ueki et al.	429/223
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2003/103080	12-2003	WIPO	Miyamoto et al.	H01M 6/08
	O					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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